	Application No.	Applicant(s)
Notice of Allowability	10/633,521	ISHIHARA ET AL.
	Examiner	Art Unit
	Huan H. Tran	2861
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI	(OR REMAINS) CLOSED in this ap or other appropriate communication GHTS. This application is subject t	oplication. If not included n will be mailed in due course. THIS
1. $\boxtimes$ This communication is responsive to <u>RCE request filed on the second se</u>	<u>08/19/05</u> .	
2. X The allowed claim(s) is/are 1-15 and 48-63.		
3.	been received.  been received in Application No cuments have been received in this  of this communication to file a reply ENT of this application.	national stage application from the complying with the requirements
5. CORRECTED DRAWINGS (as "replacement sheets") mus		
(a) ☐ including changes required by the Notice of Draftspers  1) ☐ hereto or 2) ☐ to Paper No./Mail Date  (b) ☐ including changes required by the attached Examiner's Paper No./Mail Date  Identifying indicia such as the application number (see 37 CFR 1, each sheet. Replacement sheet(s) should be labeled as such in the statement sheet in the statement sheet is should be labeled as such in the statement sheet in the statement sheet is should be labeled as such in the statement sheet in the statement sheet is should be labeled as such in the statement sheet in the statement sheet is sheet.	on's Patent Drawing Review (PTO s Amendment / Comment or in the ( 84(c)) should be written on the draw	Office action of ings in the front (not the back) of
DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT I	sit of BIOLOGICAL MATERIAL	must be submitted. Note the
Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)	6. 🔲 Interview Summary	
3. Information Disclosure Statements (PTO-1449 or PTO/SB/0	Paper No./Mail Da 8), 7. ⊠ Examiner's Amend	
Paper No./Mail Date  4.  Examiner's Comment Regarding Requirement for Deposit	8. ⊠ Examiner's Statem	ent of Reasons for Allowance
of Biological Material	9.	Huan Tran Primary Examiner AU 2861

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## **DETAILED ACTION**

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## Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after allowance or after an Office action under *Ex Parte Quayle*, 25 USPQ 74, 453 O.G. 213 (Comm'r Pat. 1935). Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, prosecution in this application has been reopened pursuant to 37 CFR 1.114. Applicant's submission filed on 08/19/05 has been entered.

## Allowable Subject Matter

- 2. Claims 1-15, 48-63 are allowed.
- 3. The following is an examiner's statement of reasons for allowance: As to claim 1 and dependent claims thereof, prior art of record do not teach or suggest –alone or in combination-the claimed optical scanning device and an image forming apparatus using the same, the scanning optical device comprises "a scanning optical system for scanning a surface to be scanned, with the light beam deflected by a deflecting means; wherein said scanning optical system includes a scanning optical element disposed so that, with respect to a sub-scan direction, a principal ray of the deflected light beam passes a portion other than an optical axis of the scanning optical system, wherein said scanning optical element has a sagittal aspherical amount changing surface in which an aspherical amount of a sagittal changes along a main scan direction of said scanning optical element, and wherein, within an effective scan range upon the surface to be scanned, the position in the sub-scan direction upon which the deflected light beam impinges is made even." The claimed scanning optical element corrects the scan line bending when the light beam is obliquely incident upon the deflecting means.

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Similarly, claim 48 and dependent claims thereof are allowable because of the inclusion of the limitations "wherein the light beam emitted from said light source means is incident on a plane, perpendicular to a rotational axis of said deflecting means, with a certain angle defined thereto, wherein said imaging optical system includes an imaging optical element disposed so that, with respect to a sub-scan direction, a principal ray of the deflected light beam passes through an inside of said imaging optical element away from an optical axis, wherein said imaging optical element has a sagittal aspherical amount changing surface in which said sagittal aspherical amount changes along a main scan direction of said imaging optical element, wherein said sagittal aspherical amount which increases along the sub-scanning direction, and wherein said sagittal aspherical amount changing surface has a sagittal curvature radius which changes along the main scan direction independently of a meridional curvature radius thereof."

Claim 56 and dependent claims thereof are allowable for the inclusion of the limitations "wherein the light beam emitted from said light source means is incident on a plane, perpendicular to a rotational axis of said deflecting means, with a certain angle defined thereto, wherein said imaging optical system includes an imaging optical element disposed so that, with respect to a sub-scan direction, a principal ray of the deflected light beam passes through a portion away from an optical axis of said imaging optical element, wherein said imaging optical element has a sagittal aspherical amount changing surface in which said sagittal aspherical amount changes along a main scan direction of said imaging optical element, and wherein said sagittal aspherical amount changing surface has a sagitlal curvature radius which changes along the main scan direction independently of a meridional curvature radius thereof"

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the

issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Huan H. Tran whose telephone number is (571) 272-2261. The examiner can normally be reached on at work on W-F from 6:30 to 5; T are telework days.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Talbott can be reached on (571) 272-1934. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Huan H. Tran Primary Examiner Art Unit 2861

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**EXAMINER'S AMENDMENT** 

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1. An examiner's amendment to the record appears below. The amendment was made to

correct an apparent typographic error. Should the changes and/or additions be unacceptable to

applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration

of such an amendment, it MUST be submitted no later than the payment of the issue fee.

The application has been amended as follows:

In the claims:

Claim 62, line 3, change "plurality o image" to -plurality of image--.

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Huan H. Trañ

Primary Examiner

Art Unit 2861

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